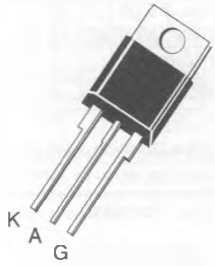
SGS-THOMSON MICROELECTRONICS

TYN 682 → 692

THYRISTORS

- GLASS PASSIVATED CHIP
- POSSIBILITY OF MOUNTING ON PRINTED CIRCUIT



TO 220 AB
(Plastic)

DESCRIPTION

SCR 's designed for motor control, heating controls, power supplies...

ABSOLUTE RATINGS (limiting values)

Symbol	Parameter		Value	Unit
$I_{T(RMS)}$	RMS on-state Current (1)	T_c = 85 °C	20	A
$I_{T(AV)}$	Mean on-state Current (1)	T_c = 85 °C	13	A
I_{TSM}	Non Repetitive Surge Peak on-state Current (T_j initial = 25 °C) (2)	t = 8.3 ms	210	A
		t = 10 ms	200	
I^2t	I^2t Value for Fusing	t = 10 ms	200	A^2s
di/dt	Critical Rate of Rise of on-state Current (3)		100	A/µs
T_{stg} T_j	Storage and Operating Junction Temperature Range		– 40 to 125 – 40 to 125	°C °C

Symbol	Parameter	TYN						Unit
		682	683	685	688	690	692	
V_{DRM} V_{RRM}	Repetitive Peak off-state Voltage (4)	50	100	200	400	600	800	V

(1) Single phase circuit, 180° conduction angle.
(2) Half sine wave.
(3) I_G = 250 mA di_G/dt = 1 A/µs.
(4) T_j = 125 °C.

THERMAL RESISTANCES

Symbol	Parameter	Value	Unit
$R_{th\ (j-c)}$	Junction-case for D.C.	2.5	°C/W
$R_{th\ (j-a)}$	Junction-ambient	60	°C/W

GATE CHARACTERISTICS (maximum values)

P_{GM} = 20 W (t_p = 20 µs) I_{FGM} = 2 A (t_p = 20 µs) V_{RGM} = 5 V

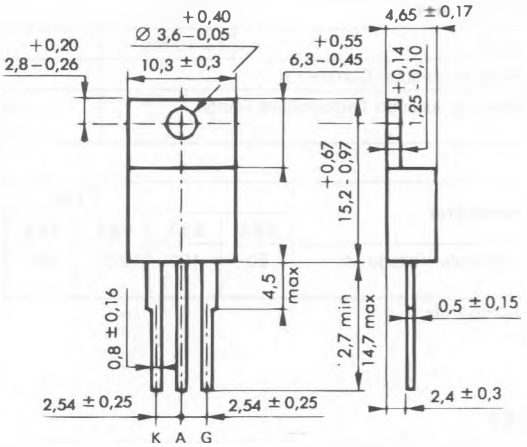
$P_{G(AV)}$ = 0.5 W V_{FGM} = 15 V (t_p = 20 µs)

ELECTRICAL CHARACTERISTICS

Symbol	Test Conditions			Min.	Typ.	Max.	Unit
I_{GT}	T_j = 25 °C Pulse Duration > 20 µs	V_D = 12 V	R_L = 33 Ω			25	mA
V_{GT}	T_j = 25 °C Pulse Duration > 20 µs	V_D = 12 V	R_L = 33 Ω			1.5	V
V_{GD}	T_j = 125 °C	V_D = V_{DRM}	R_L = 3.3 kΩ	0.2			V
I_H	T_j = 25 °C	I_T = 100 mA	Gate Open			40	mA
I_L	T_j = 25 °C Pulse Duration > 20 µs	V_D = 12 V	I_G = 50 mA		70		mA
V_{TM}	T_j = 25 °C	I_{TM} = 50 A	t_p = 10 ms			1.4	V
I_{DRM}	V_{DRM} Specified		T_j = 25 °C			0.01	mA
			T_j = 125 °C			2	
I_{RRM}	V_{RRM} Specified		T_j = 25 °C			0.01	mA
			T_j = 125 °C			2	
t_{gt}	T_j = 25 °C I_G = 80 mA	V_D = V_{DRM} di_G/dt = 0.85 A/µs	I_T = 50 A		2		µs
t_q	T_j = 125 °C V_D = 67 % V_{DRM} Gate Open	I_T = 50 A di/dt = 30 A/µs	V_R = 25 V dv/dt = 50 V/µs		70		µs
dv/dt*	T_j = 125 °C Linear Slope up to V_D = 67 % V_{DRM}	Gate Open		500			V/µs

* For higher guaranteed values, please consult us.

PACKAGE MECHANICAL DATA : TO 220 AB Plastic



Cooling method : by conduction (method C)
Marking : type number
Weight : 2 g

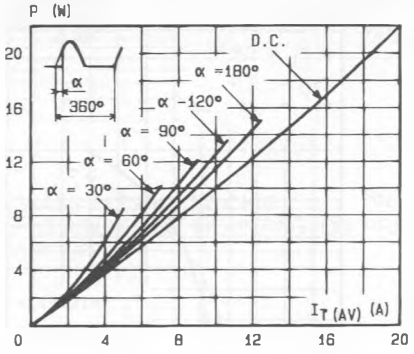


Fig.1 - Maximum mean power dissipation versus mean on-state current.

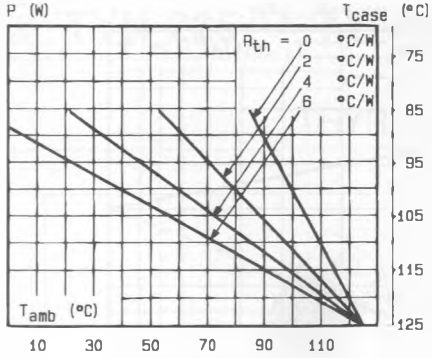


Fig.2 - Correlation between maximum mean power dissipation and maximum allowable temperatures (T_{amb} and T_{case}) for different thermal resistances heatsink + contact.

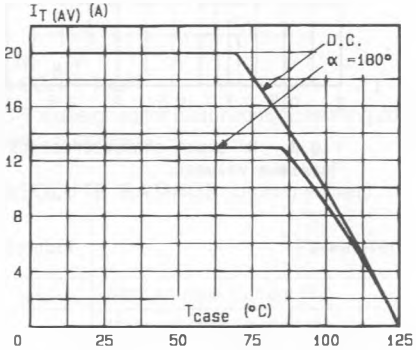


Fig.3 - Mean on-state current versus case temperature.

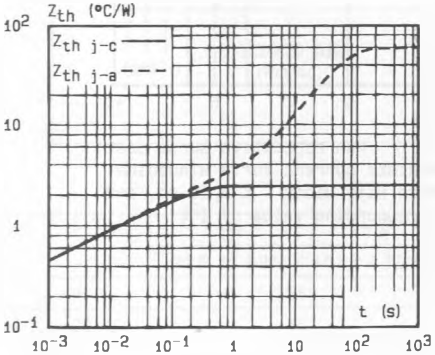


Fig.4 - Thermal transient impedance junction to case and junction to ambient versus pulse duration.

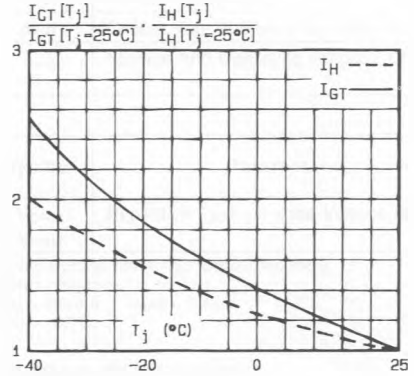


Fig.5 - Relative variation of gate trigger current and holding current versus junction temperature.

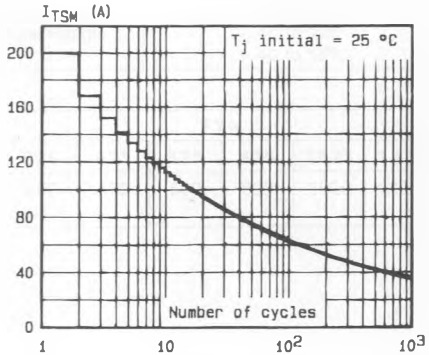


Fig.6 - Non repetitive surge peak on-state current versus number of cycles.

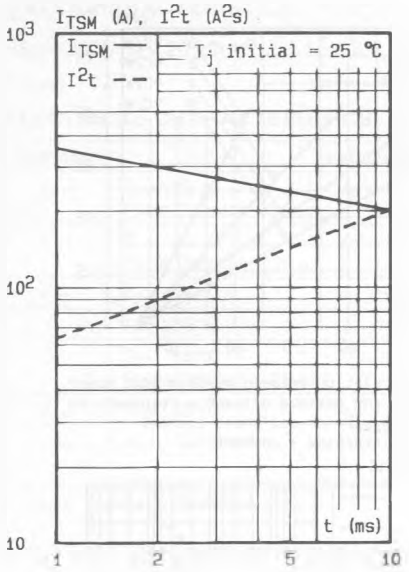


Fig.7 - Non repetitive surge peak on-state current for a sinusoidal pulse with width : t ≤ 10 ms, and corresponding value of I^2t.

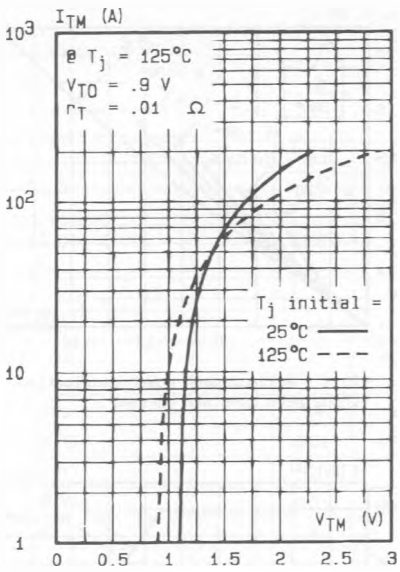


Fig.8 - On-state characteristics (maximum values).